

**Notice of References Cited**

Application/Control No.

09/955,764

Applicant(s)/Patent Under  
Reexamination  
LI ET AL.

Examiner

J. Derek Rutten

Art Unit

2122

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,146,593 A	09-1992	Brandle et al.	719/328
	B	US-5,522,073 A	05-1996	Courant et al.	719/313
	C	US-6,105,059 A	08-2000	Al-Karmi et al.	709/219
	D	US-6,282,701 B1	08-2001	Wygodny et al.	717/125
	E	US-6,311,326 B1	10-2001	Shagam, Eli	717/128
	F	US-2002/0087949 A1	07-2002	Golender et al.	717/124
	G	US-2002/0194580 A1	12-2002	Ramasamy et al.	717/130
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Blumson, Carter, and Hyde, "Automatic Insertion of Performance Instrumentation for Distributed Applications", February 1995, Technical Report, Center for Information Technology Integration, University of Michigan
	V	Peek, O'Reilly, and Loukides, "Unix Power Tools", August 1997, O'Reilly, ISBN 1-56592-260-3, Section 38.5
	W	Harkema et al., "Performance Monitoring of Java Applicatoins", July 2002, ACM, WOSP '02, ISBN 1-1-58113-563-7, pp. 114-127
	X	Jacobsen, H.-A.; Kramer, B.J., "A design pattern based approach to generating synchronization adaptors from annotated IDL", October 1998, Proceedings. 13th IEEE International Conference on Automated Software Engineering, pp. 63-72

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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	P					
	Q					
	R					
	S					
	T					

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	"Statistics Gathering and Analyzing Tool for Open Software Foundation's Distributed Computing Environment", February 1994, IBM Technical Disclosure Bulletin, Vol. 37, No. 02B, pp. 215-217
	V	
	W	
	X	

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